



## Recent results with HV-CMOS and planar sensors for the CLIC vertex detector

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On behalf of the CLICdp collaboration

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- 1 Introduction
- 2 Requirements for the vertex and tracker detectors
- 3 R&D on sensor and readout technologies
  - Characterisation of **thin** & **active-edge** planar sensors with the Timepix3 ASICs
  - CLICpix readout ASIC
  - CLICpix readout ASIC & planar sensors
  - CLICpix readout ASIC & HV-CMOS active sensor
- 4 Conclusions

## 1 Introduction

## 2 Requirements for the vertex and tracker detectors

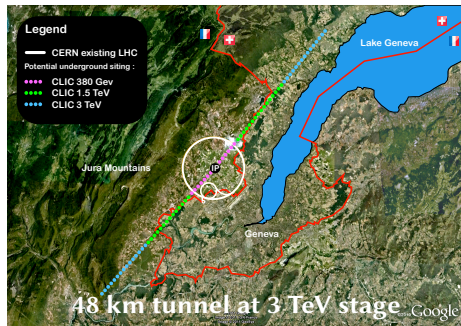
## 3 R&D on sensor and readout technologies

- Characterisation of **thin** & **active-edge** planar sensors with the Timepix3 ASICs
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## 4 Conclusions

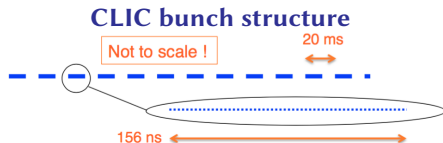
# The Compact Linear Collider (CLIC)

- A concept for an  $e^+e^-$  linear collider for the post HL-LHC period.
- Energy range  $\sqrt{s}$  : 380 GeV to 3 TeV
  - ▶ Two-beam acceleration scheme with gradients of  $\sim 100$  MV/m.
- Precision measurements of:
  - ▶ Standard Model processes (Higgs, top).
  - ▶ New physics potentially discovered at 13 TeV LHC.
  - ▶ Search for new physics: unique sensitivity to particles with electroweak charge.





# CLIC beam profile



- 1 train consists of 312 bunches with 0.5 ns spacing.

	LHC at 13 TeV	CLIC at 3 TeV
$\mathcal{L} [cm^{-2}s^{-1}]$	$1 \times 10^{34}$	$6 \times 10^{34}$
BX separation [ns]	25	0.5
#BX/train	2808	312
Train duration	90 $\mu$ s	156 ns
Train repetition	11 kHz	50 Hz
$\sigma_x / \sigma_y$ [nm]	15000/15000	$\approx 45/1$
$\sigma_z$ [nm]	$\sim 50000$	44

- Short train duration implies:
  - ▶ triggerless readout of the detectors.
  - ▶ power pulsing: allows to reduce the average power dissipation.

- Bunch separation and train duration: drive timing resolution requirements for the detectors.
- Very small beam sizes at the interaction point  $\Rightarrow$  beam-induced backgrounds:
  - ▶  $e^+e^-$  pairs: low  $p_T$ , forward peaked, limits the inner radius of the VXD.
  - ▶  $\gamma\gamma \rightarrow$  hadrons: larger  $p_T$  particles.

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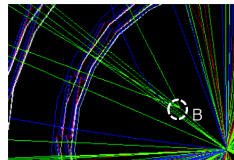
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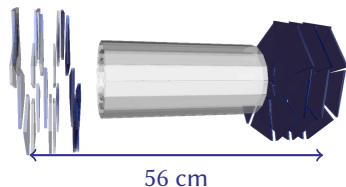
# CLIC vertex-detector requirements

- Efficient tagging of heavy quarks through a precise determination of displaced vertices can be achieved by:

- ▶ Multi-layer VXD: 6 layers in the barrel and 6 disks
- ▶ B-field: 4 T.
- ▶ Single point resolution of  $\sim 3\ \mu\text{m}$ :  $25\ \mu\text{m}$  pixel pitch & analog readout.
- ▶ Low material budget:  $< 0.2\% X_0/\text{layer}$  and beam-pipe
  - ★ forced airflow cooling & low-power electronics ( $\approx 50\ \text{mW}/\text{cm}^2$ )



- Time slicing of  $\sim 10\ \text{ns}$  to reduce the impact of beam-induced backgrounds.  
 $\Rightarrow$  high-resistive & depleted sensors, readout with precise timing.

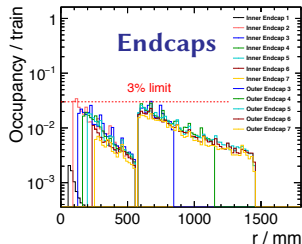
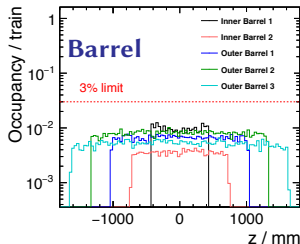
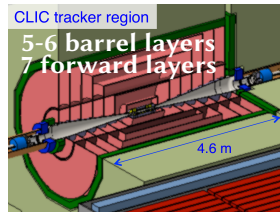


- Moderate radiation exposure of the vertex detector:

- ▶ Total ionising dose (TID):  $< 1\ \text{kGy}/\text{yr}$
- ▶ Non-ionising energy loss (NIEL):  $10^{11}\ \text{n}_{\text{eq}}/\text{cm}^2/\text{yr}$  (ATLAS phase 1:  $10^{15}\ \text{n}_{\text{eq}}/\text{cm}^2/\text{yr}$ )

# CLIC outer tracker requirements

- Momentum resolution (Higgs recoil mass,  $H \rightarrow \mu\mu$ , BSM leptons):  $\sigma(p_T)/p_T^2 \sim 2 \times 10^{-5} \text{ GeV}^{-1}$ 
  - ▶  $7 \mu\text{m}$  single-point resolution
  - ▶  $\sim 1.5 - 2\% X_0/\text{layer}$  (low-mass supports, cabling and cooling)
- Time stamping with  $\sim 10 \text{ ns}$  accuracy to reject background.
- Beam-induced background hits from  $\gamma\gamma \rightarrow \text{hadrons}$  and incoherent pairs:



- Readout granularity defined by the backgrounds occupancy of  $\sim 3\%$   
 $\Rightarrow 50 \mu\text{m}$  pitch and 1-10 mm strip lengths.

1

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2

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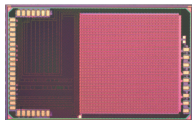
4

## Conclusions

# CLIC vertex-detector R&D programme

- Wide range of R&D activities for the CLIC VXD

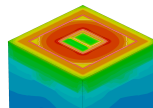
- Readout ASICs



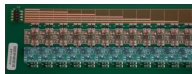
- Sensors



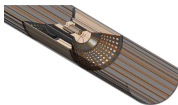
- Simulations



- Powering



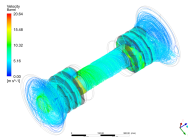
- Mechanical integration



- Light-weight supports



- Cooling

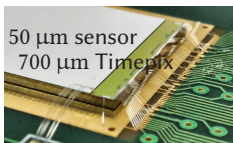


Next slides focus on recent developments on the sensor, readout R&D and simulations.

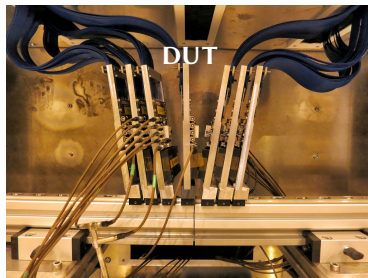
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# Thin planar sensor R&D

- The ultimate goal for CLIC:
  - ▶ 50  $\mu\text{m}$  sensor on 50  $\mu\text{m}$  readout ASIC with 25  $\mu\text{m}$  pixel-pitch.
- Feasibility of thin sensors tested with Timepix/Timepix3 readout chips:
  - ▶ 55  $\mu\text{m}$  pixel-pitch.
  - ▶ Simultaneous measurement of time (TOA) and energy (TOT).
- Sensor thicknesses: 50  $\mu\text{m}$  to 300  $\mu\text{m}$ .
- Test-beam campaigns with:
  - ▶ EUDET/AIDA telescope at DESY and CERN PS/SPS.
  - ▶ CLICpix Timepix3 telescope at CERN SPS.



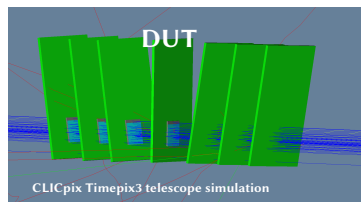
- Test-beam data is used to validate simulations and to extrapolate to pixels with a pitch of 25  $\mu\text{m}$ .
- The CLICpix Timepix3 telescope for reference tracking:
  - ▶  $\sim 2 \mu\text{m}$  pointing resolution on the device under test (DUT) for 120 GeV pions.
  - ▶  $\sim 1 \text{ ns}$  time resolution per plane.



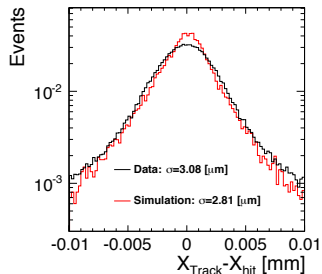


# ALLPix: a GEANT4-based simulation framework

- ALLPix: a general purpose pixel-detector simulation framework (in C/C++) based on GEANT4.
- Fully customisable for detector geometry description:
  - ▶ thickness, pixel-pitch, bump geometry, material
- Digitiser test-bench for ATLAS and CLICdp.
- **Goal:**
  - ▶ Simulate the test-beam setup.
  - ▶ Extrapolate results for small-pitch pixels (e.g. CLICpix with  $25\text{ }\mu\text{m}$  pitch).
  - ▶ Improve digitisation models for full-detector simulation.
- Good agreement between the Timepix3 telescope digitiser and the data.

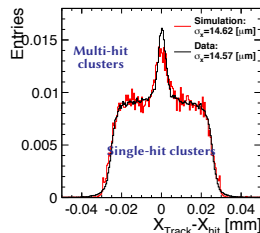
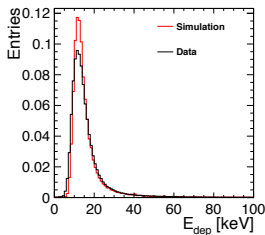
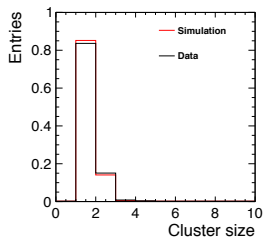


- Biased residual on the first telescope plane in x-direction:



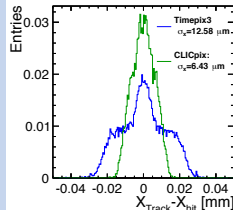
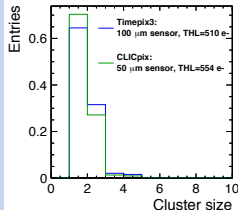
# Thin sensors test-beam results & simulation

- Validation of the ALLPix simulation with test-beam results for 50  $\mu\text{m}$ -thick sensor, 55  $\mu\text{m}$  pitch and  $\text{THL} \sim 500 \text{ e}^-$  (noise RMS for simulations: 90  $\text{e}^-$ ).



## Prediction for a 50 $\mu\text{m}$ sensor and 25 $\mu\text{m}$ pitch in simulation:

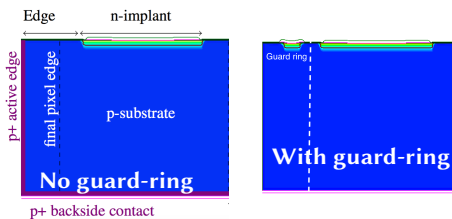
- Including the telescope tracking resolution:  $\sigma \sim 6.4 \mu\text{m}$
- New solutions needed to achieve the required single-point resolution of  $\sigma \sim 3 \mu\text{m}$ .



# Active-edge sensors

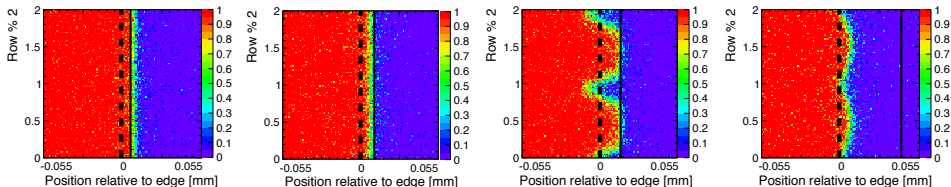
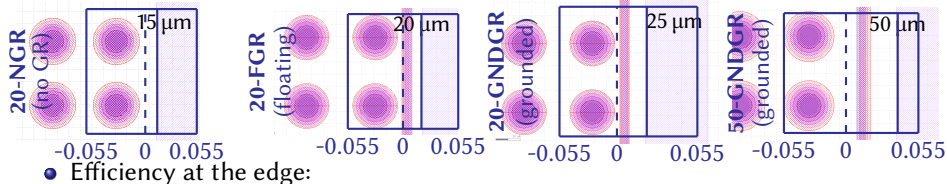
The **DRIE** (Deep Reactive-Ion Etching) process is used to cut an active-edge silicon sensor.

- Implantation on the sidewall of the sensor  $\Rightarrow$  control the potential at the edge by creating an extension of the backside electrode on the edge.
- Guard-rings: metal and n-implants to establish a smooth voltage drop between the edge and the last pixel.
- Advacam active-edge devices (n-in-p) bump-bonded to the Timepix3 ASICs:

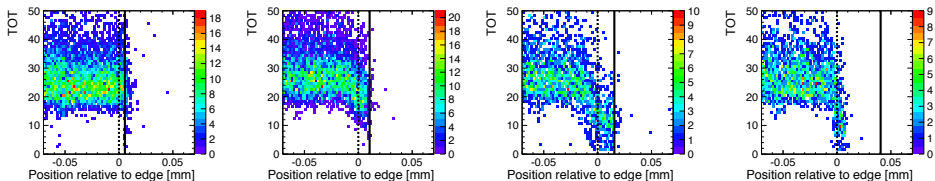


Assembly	Sensor thickness [ $\mu\text{m}$ ]	Edge width [ $\mu\text{m}$ ]	Edge type
20-NGR	50	20	No guard-ring
20-FGR	50	20	Floating guard-ring
20-GNDGR	50	20	Grounded guard-ring
50-GNDGR	50	50	Grounded guard-ring

# Active-edge planar sensors (50 $\mu\text{m}$ ): efficiency & signal

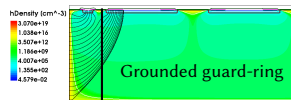
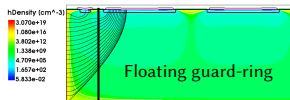
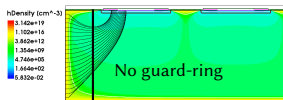


Signal at the edge:



# Conclusions on thin active-edge planar sensors

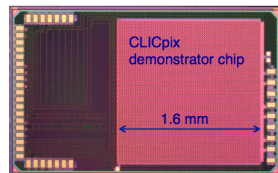
- Devices without guard-ring and with floating guard-ring are efficient up to the physical edge of the sensor.
- The grounded guard-ring is not suitable for thin sensors: for 20-GNDGR, the efficiency drops before the last pixel and in-between the pixels.
- For thin sensors, the floating guard-ring shows a compromise between the signal lost in the guard-ring and an acceptable breakdown behavior (leakage current).
- Ongoing TCAD simulation studies for different guard-ring solutions:



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# CLICpix readout ASIC demonstrator

- Hybrid readout chip: 65 nm CMOS technology
- Based on Timepix/Medipix chip family
- Intended for the CLIC vertex detector:
  - ▶ Demonstrator chip with  $64 \times 64$  matrix
  - ▶ 25  $\mu\text{m}$  pixel pitch
  - ▶ 4-bit time (TOA) & energy (TOT) measurement
  - ▶ Front-end time slicing  $< 10 \text{ ns}$
  - ▶ Data compression: pixel, cluster & column-based
  - ▶ Full chip readout in  $< 800 \mu\text{s}$ : at 10% occupancy,  $< 320 \text{ MHz}$  readout clock
  - ▶ Power-pulsing scheme:  $P_{\text{avg}} < 50 \text{ mW/cm}^2$
- Tested with:
  - ▶ bump-bonded planar sensors
  - ▶ active HV-CMOS sensors

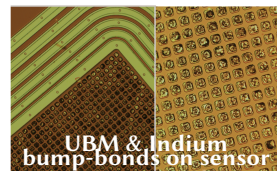


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# CLICpix: planar sensor assemblies

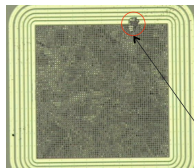
- Single-chip bump-bonding process for  $25\text{ }\mu\text{m}$  pitch  $\Rightarrow$  developed at SLAC (C. Kenney, A. Tomada).
- 3 test assemblies produced with  $200\text{ }\mu\text{m}$  n-in-p CLICpix sensors from Micron Velopix wafer.



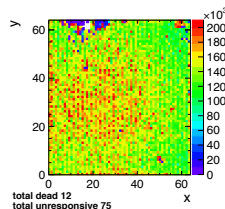
- Process flow:
  - ▶ Spin photoresist
  - ▶ Expose with contact aligner
  - ▶ Evaporator:  $4\text{ }\mu\text{m}$  Indium
  - ▶ Lift-off
  - ▶ bumping
- Correlation between **unconnected** and **shorted** pixels with defects visible before flipping.

- Defects due to the indium solder bumps (did not stick everywhere):

- ▶ 0.2-3% **unconnected** channels
- ▶ 1-2% **shorted** channels

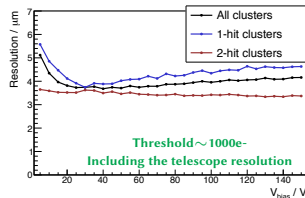
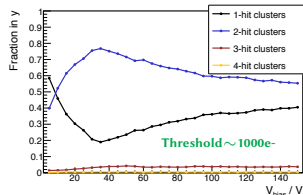
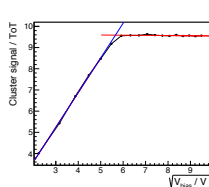


- Laboratory measurements with the  $^{90}\text{Sr}$  source:

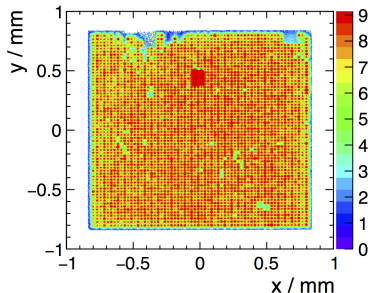


# CLICpix: planar sensor test-beam results

- Beam-tests with the EUDET/AIDA telescope at CERN SPS H6B
- Depletion voltage at 35 V with maximal charge sharing and best resolution of 4  $\mu\text{m}$  (including the telescope resolution of 1.6  $\mu\text{m}$ ).



- High detection efficiency:  $> 99\%$
- Average signal of leading pixel in cluster in test-beam
  - ▶ Identification of dead and shorted pixels
  - ▶ In shorted pixels, the charge is shared  $\Rightarrow$  reduced.

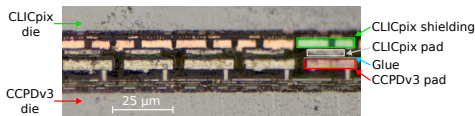


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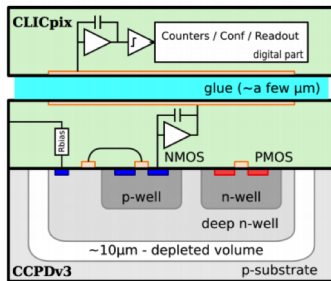
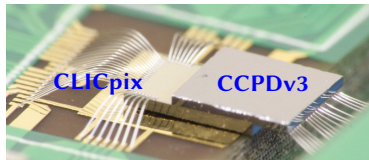
# HV-CMOS active sensor with capacitive coupling

- Capacitive coupled pixel detector (CCPDv3) used as active sensor integrating **sensor** & **amplifier**

- Commercial 180 nm HV-CMOS process.
- Two-stage amplifier in each pixel:  
 $t_{\text{peak}} = 120 \text{ ns}$ .
- Deep n-well shields electronics from substrate bias  $\Rightarrow$  prevents charge loss to electronics wells.
- Biased at 60 V  $\Rightarrow$  create a depletion layer with fast signal collection through drift.
- Through a layer of glue, the CCPDv3 chip is capacitively coupled from its amplifier output to the CLICpix readout ASIC  $\Rightarrow$  no bump-bonding.

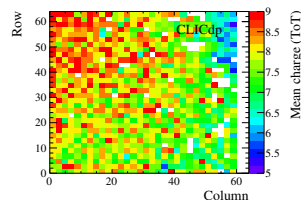
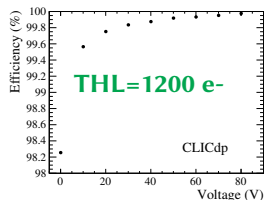
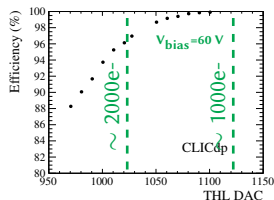


- 250  $\mu\text{m}$ -thick sensor



# CCPDv3-CLICpix test-beam results

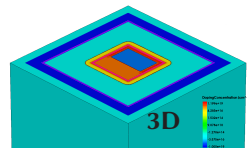
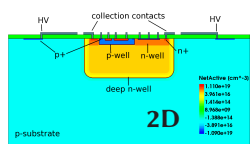
- Test-beam at CERN SPS with EUDET/AIDA telescope:
  - ▶ High detection efficiency even without bias
  - ▶ Non-uniformity of the glue thickness can be seen in the variation of the measured mean charge (TOT) across matrix
  - ▶  $\sim 6\ \mu\text{m}$  single-point resolution.



- Proof of principle for HV-CMOS sensors achieved
- Updated CLICpix2 readout ASIC ( $128 \times 128$  matrix) and HV-CMOS sensors are being produced based on the results obtained from CCPDv3 and bump-bonded planar sensors.

# TCAD simulation of CCPDv3

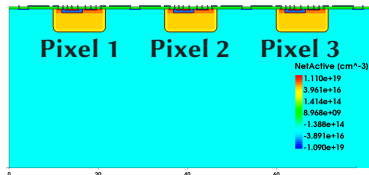
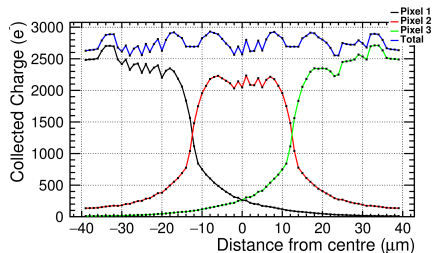
- n-in-p CCPDv3 pixel layout implemented in TCAD:



- 3D simulations used to prove 2D simulation

- MIP scan and charge collected by the neighbouring pixels after a timing integration of 100 ns:

- ▶ Uniform charge collection
- ▶ Diffusion to neighbouring pixels



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# Conclusions

- Challenging requirements for the CLIC vertex detector and tracker.
- A very active R&D on sensor and readout ASICs
  - ▶ Thin planar sensors with Timepix3 readout, validation of simulations and prediction of resolution for the final CLIC requirements.
  - ▶ Different guard-ring solutions for thin active-edge sensors tested.
  - ▶ CLICpix ASICs
    - ★ Planar sensors bump-bonded successfully to fine  $25\text{ }\mu\text{m}$  pitch.
    - ★ Proof of principle for the HV-CMOS active sensors achieved



# Thanks for your attention!



Compact Linear Collider

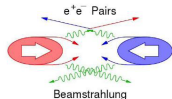


# Backup slides

# Beam-induced backgrounds at CLIC

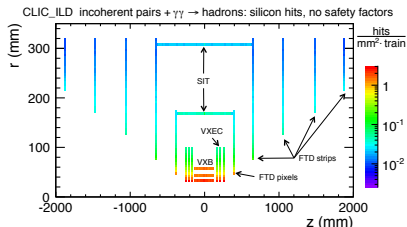
- Backgrounds:

- ▶  $e^+e^-$  pairs: low  $p_T$ , forward peaked, limits the inner radius of the VXD.
- ▶  $\gamma\gamma \rightarrow$  hadrons: larger  $p_T$  particles.



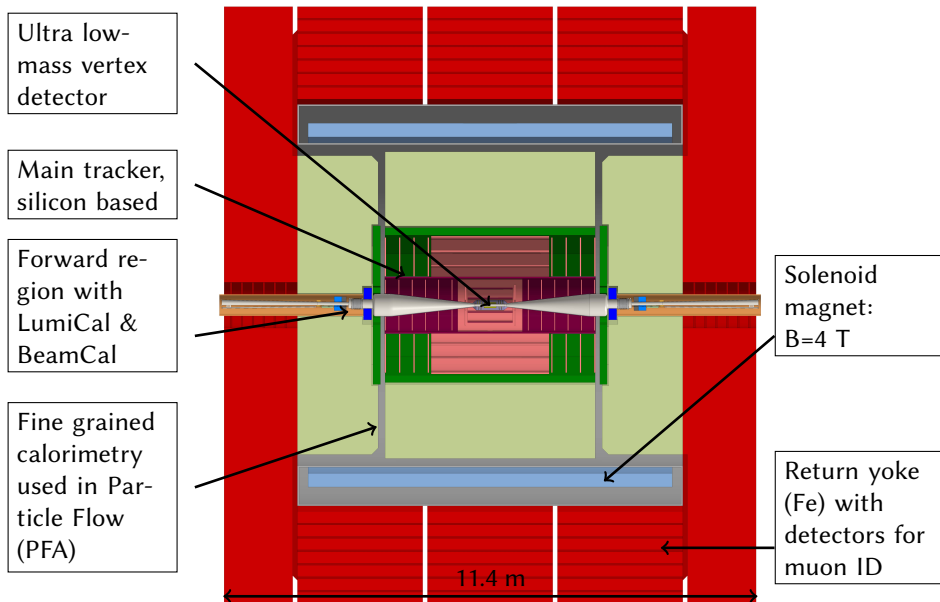
- Each train consists of:

- ▶ At most 1 interesting event.
- ▶ > 30000 background particles inside the detector.



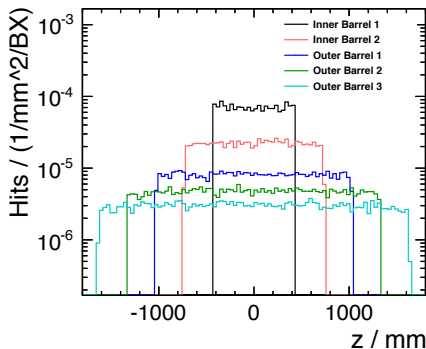
- Occupancy in the pixel detectors for each train (during 156 ns):  $\sim 3\%$  for innermost layers.
- Radiation exposure of the vertex detector is moderate:
  - ▶ Total ionising dose (TID): 200 Gy/yr
  - ▶ Non-ionising energy loss (NIEL):  $10^{11} n_{eq}/\text{cm}^2/\text{yr}$  (for ATLAS phase 1:  $10^{15} n_{eq}/\text{cm}^2/\text{yr}$ )

# CLIC detector concept

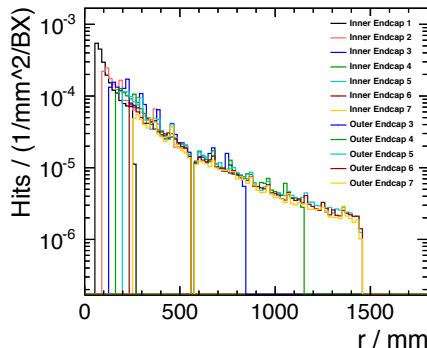


# Occupancy in the tracker

- $B=4\text{ T}$
- $50\text{ }\mu\text{m}$  pitch in the tracker
- Barrel strip lengths:
  - ▶ Layers 1 & 2: 1 mm
  - ▶ Layer 3: 5 mm
  - ▶ Layers 4 & 5: 10 mm



- Endcap strip lengths:
  - ▶ Inner discs: 1 mm
  - ▶ Outer discs: 10 mm



# Leakage current in active-edge sensors

- Sensor type: n-in-p
- IV-curve measurement for all the tested assemblies:
  - ▶ The sensor without any guard-ring (20-NGR) has the highest leakage current and the break-down occurs earlier.

